

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/717,220	<b>Applicant(s)/Patent under Reexamination</b> FARIS, SADEG M.
	<b>Examiner</b> Chuong A. Luu	<b>Art Unit</b> 2818

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner